UC1854A





ADVANCED HIGH-POWER FACTOR PREREGULATOR

FEATURES

- Controls Boost PWM to Near-Unity Power Factor
- Limits Line Current Distortion To <3%
- World-Wide Operation Without Switches
- Accurate Power Limiting
- Fixed-Frequency Average Current-Mode Control
- High Bandwidth (5 MHz), Low-Offset Current Amplifier
- Integrated Current- and Voltage-Amplifier Output Clamps
- Multiplier Improvements: Linearity, 500 mV V_{AC}
 Offset (Eliminates External Resistor), 0 V to
 5 V Multout Common-Mode Range
- V_{REF} GOOD Comparator
- Faster and Improved Accuracy ENABLE Comparator
- UVLO Options (16 V/10 V or 10.5 V/10 V)
- 300-μA Start-Up Supply Current

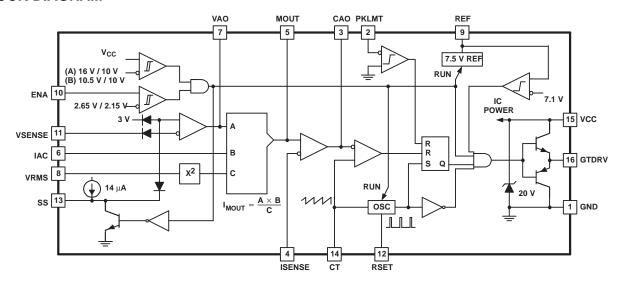
DESCRIPTION

The UC3854A/B products are pin compatible enhanced versions of the UC3854. Like the UC3854, these products provide all of the functions necessary for active power factor corrected preregulators. The controller achieves near unity power factor by shaping the ac input line current waveform to correspond to the ac input line voltage. To do this the UC3854A/B uses average current mode control. Average current mode control maintains stable, low distortion sinusoidal line current without the need for slope compensation, unlike peak current mode control.

A 1%, 7.5-V reference, fixed frequency oscillator, PWM, voltage amplifierwith soft-start, line voltage feedforward (V_{RMS} squarer), input supply voltage clamp, and over current comparator round out the lilst of feataures.

Available in the 16-pin N (PDIP), DW (SOIC Wide), and J (CDIP) and 20-pin Q (PLCC) package. See Ordering Information table for availability by temperature range.

BLOCK DIAGRAM





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

DESCRIPTION (CONTINUED)

The UC3854A/B products improve upon the UC3854 by offering a wide bandwidth, low offset current amplifier, a faster responding and improved accuracy enable comparator, a VREF GOOD comparator, UVLO threshold options (16 V/10 V for offline, 10.5 V/10 V for startup from an auxiliary 12-V regulator), lower startup supply current, and an enhanced multiply/divide circuit. New features like the amplifier output clamps, improved amplifier current sinking capability, and low offset VAC pin reduce the external component count while improving performance. Improved common mode input range of the multiplier output/current amplifier input allow the designer greater flexibility in choosing amethod for current sensing. Unlike its predecessor, R_{SET} controls only oscillator charging current and has no effect on clamping the maximum multiplier output current. This current is now clamped to a maximum of $2\times I_{\text{AC}}$ at all times which simplifies the design process and provides foldback power limiting during brownout and extreme low line conditions.

ORDERING INFORMATION

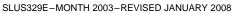
	UVLO	UVLO		PART NUMBERS						
T _A	TURN-ON (V)	TURN-OFF (V)	CDIP-16 (V)	PDIP-16 (N)	SOIC-16 (DW)	PLCC-20 (Q)				
FF9C to 12F9C	16	10	_	_	_	_				
–55°C to 125°C	10.5	10	UC1854BJ	_	_	_				
400C to 050C	16	10	UC2854AJ	UC2854AN	UC2854ADW	UC2854AQ				
–40°C to 85°C	10.5	10	UC2854BJ	UC2854BN	UC2854BDW	UC2854BQ				
000 to 7000	16	10	_	UC2854AN	UC2854ADW	_				
0°C to 70°C	10.5	10	_	UC2854BN	UC2854BDW	_				

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)(1)

			UCX854A, UCX854B	UNIT	
V _{CC}	Supply voltage		22	V	
	GTDRV current	Continuous	0.5	۸	
IGTDRV	GTDRV GTDRV current	50% duty cycle	1.5	- A	
	Innut voltogo	VSENSE, VRMS, ISENSE MOUT	11	V	
	Input voltage	PKLMT	5] v	
	Input current	RSET, IAC, PKLMT, ENA	10	mA	
	Power dissipation		1	W	
TJ	Junction temperatu	re	-55 to 150		
T _{stg}	Storage temperatur	е	-65 to 150	°C	
T _{sol}	Lead temperataure,	1,6 mm (1/16 inch) from case for 10 seconds	300		

⁽¹⁾ Stresses beyond those listed under absolutemaximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periodsmayaffect device reliability. All voltages arewith respect to GND. Currents are positive into and negative out of, the specified terminal. ENA input is internally clamped to approximately 10 V.





RECOMMENDED OPERATING CONDITIONS

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Supply voltage		10	20	V
		UC1854X	-55	125	
T_{J}	Γ _J Operating junction temperature	UC2854X	-40	85	°C
		UC3854X	0	70	

THERMAL RESISTANCE

	PACKAGED DEVICES							
RESISTANCES	CDIP-16 (J)	PDIP-16 (N)	SOP-16 (DW)	PLCC-20 (Q)				
θ _{JC} (°C/W)	28 ⁽¹⁾	45	27	34				
θ _{JA} (°C/W)	80–120	90 ⁽²⁾	50-130 ⁽²⁾	43–75 ⁽²⁾				

⁽¹⁾ θ_{JC} data values stated are derived from MIL-STD-1835B which states gthe baseline values shown are worst case (mean +2s) for a 60 imes 60 mil microcircuit device silicon die and applicable for devices with die sizes up to 14,400 square mils. For device die sizes greater than 14,400 square mils use the following values, dual-in-line, 11°C/W; flat pack and pin grid array, 10°C/W.are at the end of each trace.

⁽²⁾ θ_{JA} (junction-to-ambient) applies to devices mounted to five square inch FR4 PC board with one ounce copper where noted. When resitance range is given, lower values are for five square inch aluminum PC board. Test PWB is 0.062 inches thick and typically uses 0,635 mm trace widths for power packages and 1,3 mm trace widths for non-power packages with a 100 × 100 mil probe land are at the end of each trace.



ELECTRICAL CHARACTERISTICS

 $V_{CC}=18~V,~R_T=8.2~k\Omega,~C_T=1.5~nF,~V_{PKLMT}=1~V,~V_{VRMS}=1.5~V,~I_{IAC}=100~\mu\text{A},~I_{ISENSE}=0~V,~V_{CAO}=3.5~V,~V_{VAO}=5~V,~V_{VSENSE}=3~V,~-40^{\circ}C<T_A<85^{\circ}C~for~the~UC2854A~and~UC2854B,~and~0^{\circ}C<T_A<70^{\circ}C~for~the~UC3854A~and~UC3854B,~and~T_A=T_J~(unless~otherwise~noted)$

	PARAMETER	TEST CO	ONDITIONS	MIN	TYP	MAX	UNIT
OVERA	LL						
	Supply current, off	$CAO = 0 V,$ $V_{CC} = V_{UVLO} - 0.3 V$	VAO = 0 V,		250	400	μΑ
	Supply current, on				12	18	mA
	\/ turn on threehold voltage	UCx854A		15.0	16.0	17.5	
	V _{CC} turn-on threshold voltage	UCx854B		8.0	10.5	11.2	
	\\ tume off the made also valte as	UCx854A		9	10	12	
	V _{CC} turn-off threshold voltage	UCx854B		7.8	10.3	11.0	V
	V hustanasia	UCx854A		5	6	7	
	V _{CC} hysteresis	UCx854B		0.10	0.22	0.50	
	V _{CC} clamp	$I_{VCC} = I_{VCC(on)} + 5 \text{ mA}$	1	18	20	22	
VOLTA	GE AMPLIFIER						
	Input voltage			2.9	3.0	3.1	V
	V _{SENSE} bias current			-500	—25	500	nA
	Open loop gain	2 V ≤ V _{OUT} ≤ 5 V		70	100		dB
V _{OH}	High-level output voltage	$I_{LOAD} = -500 \mu\text{A}$			6		
V _{OL}	Low-level output voltage	I _{LOAD} = 500 μA			0.3	0.5	V
I _{SC}	Output short-circuit current	V _{OUT} = 0 V			1.5	3.5	mA
	Gain bandwidth product ⁽¹⁾	f _{IN} = 100 kHz,	10 mVp-p		1		MHz
CURRE	NT AMPLIFIER		-				
	hand affect well-	$V_{CM} = 0 V$,	$T_A = 25^{\circ}C$	-4		0	
	Input offset voltage	$V_{CM} = 0 V$,	Overtemperature	-5.5		0	mV
I _{SENSE}	Input bias current	V _{CM} = 0 V		-500		500	nA
	Open loop gain	2 V ≤ V _{OUT} = 6 V		80	110		dB
V _{OH}	High-level output voltage	$I_{LOAD} = -500 \mu A$			8		
V _{OL}	Low-level output voltage	$I_{LOAD} = 500 \mu\text{A}$			0.3	0.5	V
I _{SC}	Output short-circuit current	V _{OUT} = 0 V			1.5	3.5	mA
CMRR	Common mode rejection range			-0.3		5.0	V
	Gain bandwidth product ⁽¹⁾	f _{IN} = 100 kHz,	10 mVp-p	3	5		MHz
REFERI	ENCE		-				
	Outroot colteres	$I_{REF} = 0 \text{ mA},$	7.4	7.5	7.6	V	
	Output voltage	I _{REF} = 0 mA	7.35	7.50	7.65		
	Load regulation	1 mA ≤ I _{REF} ≤ 10 mA	0	8	20		
	Line regulation	12 V ≤ V _{CC} ≤ 18 V	0	14	25	mV	
I _{SC}	Short circuit current	V _{REF} = 0 V		25	35	60	mA

⁽¹⁾ Ensured by design. Not production tested.



ELECTRICAL CHARACTERISTICS (Continued)

 $V_{CC}=18~V,~R_T=8.2~k\Omega,~C_T=1.5~nF,~V_{PKLMT}=1~V,~V_{VRMS}=1.5~V,~I_{IAC}=100~\mu\text{A},~I_{ISENSE}=0~V,~V_{CAO}=3.5~V,~V_{VAO}=5~V,~V_{VSENSE}=3~V,~-40^{\circ}C<T_A<85^{\circ}C~for~the~UC2854A~and~UC2854B,~and~0^{\circ}C<T_A<70^{\circ}C~for~the~UC3854A~and~UC3854B,~and~T_A=T_J~(unless~otherwise~noted)$

	PARAMETER	TEST	CONDITIONS	MIN	TYP	MAX	UNIT
OSCIL	LATOR			1		•	
	Initial accuracy	T _A = 25°C		85	100	115	kHz
	Voltage stability	12 V ≤ V _{CC} ≤ 18 V			1%		
	Total variation	Line, temperature		80		120	kHz
	Ramp amplitude (peak-to-peak)			4.9		5.9	V
	Ramp valley voltage			0.8		1.3	V
ENABL	E/SOFT-START/CURRENT LIMIT	<u>"</u>				'	
	Enable threshold voltage			2.35	2.55	2.80	V
	Enaable hysteresis	V _{FAULT} = 2.5 V			500	600	mV
	Enable input bias current	V _{ENA} = 0 V			-2	-5	μΑ
	Propagation delay to disable time ⁽¹⁾	Enable overdrive =	= 100 mV		300		ns
	Soft-start charge current	V _{SS} = 2.5 V		10	14	24	μΑ
	Peak limit offset voltage			-15		15	mV
	Peak limit offset current	V _{PKLMIT} = -0.1 V		-200	-100		μΑ
	Peak limit propagation delay time (1)				150		ns
MULTI	PLIER						
	Output current, I _A limited	I_{AC} = 100 μA, R_{SET} = 10 kΩ	$V_{RMS} = 1 V$,	-220	-200	-170	μΑ
	Output current, zero	$I_{AC} = 0 \mu A$,	$R_{SET} = 10 \text{ k}\Omega$	-2.0	-0.2	2.0	μΑ
	Output current, power limited	V _{RMS} = 1.5 V	Va = 6 V	-230	-200	-170	μΑ
		V _{RMS} = 1.5 V	Va = 2 V		-22		
	Output summer	V _{RMS} = 1.5 V	Va = 5 V		-156		^
	Output current	$V_{RMS} = 5 V$	Va = 2 V		-2		μΑ
		$V_{RMS} = 5 V$	Va = 5 V		-14		
	Gain constant ⁽²⁾	V _{RMS} = 1.5 V	Va = 6 V, T _A = 25°C	-1.1	-1.0	-0.9	A/A
GATE	DRIVER						
V _{OH}	High-level output voltage	$I_{OUT} = -200 \text{ mA},$	V _{CC} = 15 V	12.0	12.8		V
V _{OL}	Low-level output voltage	I _{OUT} = 200 mA			1.0	2.2	V
		I _{OUT} = 10 mA			300	500	mV
	Low-level UVLO voltage	$I_{OUT} = 50 \text{ mA},$	$V_{CC} = 0 V$		0.9	1.5	V
	Output rise time ⁽¹⁾	C _{LOAD} = 1 nF			35		ns
	Output fall time ⁽¹⁾	C _{LOAD} = 1 nF			35		ns
	Output peak current ⁽¹⁾	C _{LOAD} = 10 nF			1.0		Α

(1) Ensured by design. Not production tested.

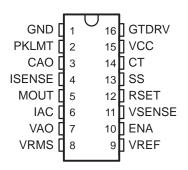
$$(K) = \frac{I_{IAC} \times (V_{VAO} - 1.5V)}{\left[(V_{VRMS})^2 \times I_{MOUT} \right]}$$

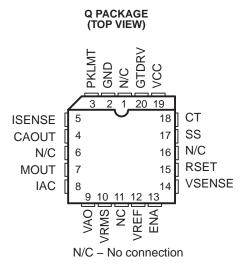
(2) Gain constant.

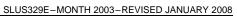


PACKAGE DESCRIPTION

J, N and DW PACKAGES (TOP VIEW)









TERMINAL FUNCTIONS

TE	RMINAL								
NAME	PACKA	GES	I/O	DESCRIPTION					
NAIVIE	J/N/DW	Q/L							
CAO	3	4	0	Output of the wide bandwidth current amplifier and one of the inputs to the PWM duty-cycle comparator. The output signal generated by this amplifier commands the PWM to force the correct input current. The output can swing from 0.1 V to 7.5 V.					
CT	14	18	I	Capacitor from CT to GND sets the PWM oscillator frequency.					
ENA	10	13	I	A nominal voltage above 2.65 V on this pin allows the device to begin operating. Once operating, the device shuts off if this pin goes below 2.15 V nominal.					
GND	1	2	_	All bypass and timing capacitors connected to GND should have leads as short and direct as possible. All voltages are measured with respect GND.					
GTDRV	16	20	0	Output of the PWM is a 1.5-A peak totem-pole MOSFET gate driver on GTDRV. Use a series gate resistor of at least 5 Ω to prevent interaction between the gate impedance and the GTDRV output driver that might cause the GTDRV output to overshoot excessively. Some overshoot of the GTDRV output is always expected when driving a capacitive load.					
IAC	6	8	I	Current input to the multiplier, proportional to the instantaneous line voltage. This input to the analog multiplier is a current. The multiplier is tailored for very low distortion from this current input (IAC) to MOUT, so this is the only multiplier input that should be used for sensing instantaneous line voltage.					
ISENSE	4	5	I	Switch current sensing input. This is the inverting input to the current amplifier. This input and the non-inverting input MOUT remain functional down to and below GND. Care should be taken to avoid taking these inputs below –0.5 V, because they are protected with diodes to GND.					
MOUT	5	7	I/O	Multiplier output and current sense plus. The output of the analog multiplier and the non-inverting input of the current amplifier are connected together at MOUT. The cautions about taking ISENSE below -0.5 V also apply to MOUT. As the multiplier output is a current, this is a high-impedance input similar to I_{SENSE} , so the current amplifier can be configured as a differential amplifier to reject GND noise. $I_{MOUT} \le 2 \times I_{AC}$					
PKLMT	2	3	I	Peak limit. The threshold for PKLMT is 0.0 V. Connect this input to the negative voltage on the current sense resistor. Use a resistor to REF to offset the negative current sense signal up to GND					
RSET	12	15	I	Oscillator charging current and multiplier limit set. A resistor from RSET to ground programs oscillator charging current.					
SS	13	17	I	Soft-start. SS remains at GND as long as the device is disabled or V_{CC} is too low. SS pulls up to over 3 V by an internal 14- μ A current source when both V_{CC} becomes valid and the device is enabled. SS acts as the reference input to the voltage amplifier if SS is below VREF. With a large capacitor from SS to GND, the reference to the voltage regulating amplifier rises slowly, and increase the PWM duty cycle slowly. In the event of a disable command or a supply dropout, SS will quickly discharge to ground and disable the PWM.					
VAO	7	9	I	Voltage amplifier output					
VCC	15	19	I	Positive supply rail					
VREF	9	12	0	Used to set the peak limit point and as an internal reference for various device functions. This voltage must be present for the device to operate.					
VRMS	8	10	I	One of the inputs into the multiplier. This pin provides the input RMS voltage to the multiplier circuitry.					
VSENSE	11	14	ı	This pin provides the feedback from the output. This input goes into the voltage error amplifier and the output of the error amplifier is another of the inputs into the multiplier circuit.					

FUNCTIONAL DESCRIPTION

The UC3854A and UC3854B family of products are designed as pin compatible upgrades to the industry standard UC3854 active power factor correction circuits. The circuit enhancements allow the user to eliminate in most cases several external components currently required to successfully apply the UC3854. In addition, linearity improvements to the multiply, square and divide circuitry optimizes overall system performance. Detailed descriptions of the circuit enhancements are provided below. For in-depth design applications reference data refer to the application notes, UC3854 Controlled Power Factor Correction Circuit Design (SLUA144) and UC3854A and UC3854B Advanced Power Factor Correction Control ICs (SLUA177).

Multiply/Square and Divide

The UC3854A/B multiplier design maintains the same gain constant $K = \frac{1}{V}$ as the UC3854. The relationship between the inputs and output current is given as:

$$I_{MOUT} = I_{LAC} \times \frac{\left(V_{VAO} - 1.5V\right)}{K \times \left(V_{VRMS}\right)^2} \tag{1}$$

This is nearly the same as the UC3854, but circuit differences have improved the performance and application.

The first difference is with the IAC input. The UC3854A/B regulated this pin voltage to the nominal 500 mV over the full operating temperature range, rather than the 6.0 V used on the UC3854. The low offset voltage eliminates the need for a line zero crossing compensating resistor to VREF from IAC that UC3854 designs require. The maximum current at high line into IAC should be limited to 250 μ A for best performance.

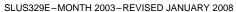
Therefore, if $V_{VAC(max)} = 270 \text{ V}$,

$$R_{LAC} = \frac{270 \times 1.414}{250 \,\mu A} = 1.53 M\Omega \tag{2}$$

The V_{RMS} pin linear operating range is improved with the UC3854A/B as well. The input range for VRMS extends from 0 V to 5.5 V. Since the UC3854A squaring circuit employs an analog multiplier, rather than a linear approximation, accuracy is improved, and discontinuities are eliminated. The external divider network connected to VRMS should produce 1.5 V at low line (85 VAC). This puts 4.77 V on VRMS at high line (270 VAC) which is well within its operating range.

The voltage amplifier output forms the third input to the multiplier and is internally clamped to 6.0 V. This eliminated an external zener clamp often used in UC3854 designs. The offset voltage at this input to the multiplier has been raised on the UC3854A/B to 1.5 V.

The multiplier output pin, which is also common to the current amplifier non-inverting input, has a -0.3 V to 5.0 V output range, compared to the -0.3 V to 2.5 V range of the UC3854. This improvement allows the UC3854A/B to be used in applications where the current sense signal amplitude is very large.





Voltage Amplifier

The UC3854A/B voltage amplifier design is essentially similar to the UC3854 with two exceptions. The first is with the internal connection. The lower voltage reduces the amount of charge on the compensation capacitors, which provides improved recovery form large signal events, such as line dropouts, or power interruption. It also minimizes the dc current flowing through the feedback. The output of the voltage amplifier is also changed. In addition to a 6.0-V temperature compensated clamp, the output short circuit current has been lowered to 2 mA typical, and an active pull down has replaced the passive pull down of the UC3854.

Current Amplifier

The current amplifier for an average current PFC controller needs a low offset voltage in order to minimize ac line current distortion. With this in mind, the UC3854A/B current amplifier has improved the input offset voltage from ±4 mV to 0 V to ±3 mV. The negative offset of the UC3854A/B assures that the PWM circuit will not drive the MOSFET is the current command is zero (both current amplifier inputs zero.) Previous designs required an external offset cancellation network to implement this key feature. The bandwidth of the current amplifier has been improved as well to 5 MHz typical. While this is not generally an issue at 50 Hz or 60 Hz inputs, it is essential for 400 Hz input avionics applications.

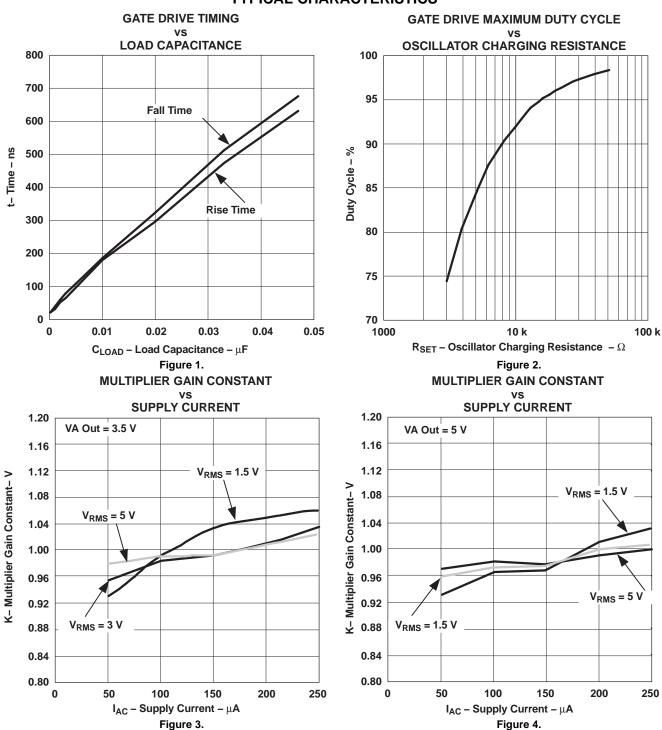
Miscellaneous

Several other important enhancements have been implemented in the UC3854A/B. AV_{CC} supply voltage clamp at 20 V allows the controller to be current fed if desired. The lower startup supply current (250 μ A typical), substantially reduces the power requirements of an offline startup resistor. The 10.5 V/10 V UVLO option (UC3854B) enables the controller to be powered off of an auxiliary 12-V supply.

The VREF GOOD comparator assures that the MOSFET driver output remains low if the supply of the 7.5 V reference are not yet up. This improvement eliminates the need for external Schottky diodes on the PKLMT and Mult Out pins that some UC3854 designs require. The propagation delay of the disable feature has been improved to 300 ns typical. This delay was proportional to the size of the VREF capacitor on the UC3854, and is typically several orders of magnitude slower.

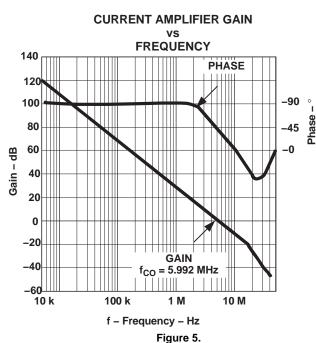


TYPICAL CHARACTERISTICS





TYPICAL CHARACTERISTICS (continued)



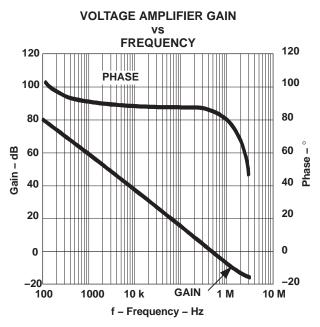


Figure 6.



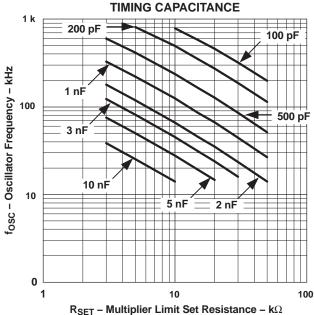


Figure 7.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
5962-9326102MEA	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9326102ME A UC1854BJ/883B
UC1854BJ	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	UC1854BJ
UC1854BJ.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	UC1854BJ
UC1854BJ883B	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9326102ME A UC1854BJ/883B
UC1854BJ883B.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9326102ME A UC1854BJ/883B
UC2854ADW	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UC2854ADW
UC2854ADW.A	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UC2854ADW
UC2854ADWTR	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UC2854ADW
UC2854ADWTR.A	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UC2854ADW
UC2854AN	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	UC2854AN
UC2854AN.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	UC2854AN
UC2854ANG4	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	UC2854AN
UC2854BDW	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UC2854BDW
UC2854BDW.A	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UC2854BDW
UC2854BDWG4	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UC2854BDW
UC2854BDWTR	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UC2854BDW
UC2854BDWTR.A	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UC2854BDW
UC2854BDWTRG4	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	UC2854BDW
UC2854BN	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	UC2854BN
UC2854BN.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	UC2854BN
UC2854J	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-40 to 85	UC2854J
UC2854J.A	Active	Production	CDIP (J) 16	25 TUBE	No	SNPB	N/A for Pkg Type	-40 to 85	UC2854J
UC3854ADW	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854ADW
UC3854ADW.A	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854ADW
UC3854ADWG4	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854ADW





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Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking
	(-)	(=)			(=)	(4)	(5)		(-)
UC3854ADWTR	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854ADW
UC3854ADWTR.A	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854ADW
UC3854ADWTRG4	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854ADW
UC3854AN	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	UC3854AN
UC3854AN.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	UC3854AN
UC3854ANG4	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	UC3854AN
UC3854BDW	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854BDW
UC3854BDW.A	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854BDW
UC3854BDWG4	Active	Production	SOIC (DW) 16	40 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854BDW
UC3854BDWTR	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854BDW
UC3854BDWTR.A	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854BDW
UC3854BDWTRG4	Active	Production	SOIC (DW) 16	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	UC3854BDW
UC3854BN	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	UC3854BN
UC3854BN.A	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	UC3854BN
UC3854BNG4	Active	Production	PDIP (N) 16	25 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	UC3854BN

⁽¹⁾ Status: For more details on status, see our product life cycle.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

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Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF UC1854B, UC2854B, UC2854M, UC3854B:

Catalog: UC3854B, UC2854

Enhanced Product : UC2854B-EP

Military: UC2854BM, UC1854B

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Enhanced Product Supports Defense, Aerospace and Medical Applications
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
UC2854ADWTR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
UC2854BDWTR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
UC3854ADWTR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
UC3854BDWTR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
UC2854ADWTR	SOIC	DW	16	2000	353.0	353.0	32.0
UC2854BDWTR	SOIC	DW	16	2000	353.0	353.0	32.0
UC3854ADWTR	SOIC	DW	16	2000	353.0	353.0	32.0
UC3854BDWTR	SOIC	DW	16	2000	353.0	353.0	32.0



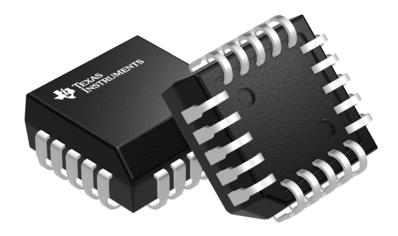
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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
UC2854ADW	DW	SOIC	16	40	507	12.83	5080	6.6
UC2854ADW.A	DW	SOIC	16	40	507	12.83	5080	6.6
UC2854AN	N	PDIP	16	25	506	13.97	11230	4.32
UC2854AN.A	N	PDIP	16	25	506	13.97	11230	4.32
UC2854ANG4	N	PDIP	16	25	506	13.97	11230	4.32
UC2854BDW	DW	SOIC	16	40	507	12.83	5080	6.6
UC2854BDW.A	DW	SOIC	16	40	507	12.83	5080	6.6
UC2854BDWG4	DW	SOIC	16	40	507	12.83	5080	6.6
UC2854BN	N	PDIP	16	25	506	13.97	11230	4.32
UC2854BN.A	N	PDIP	16	25	506	13.97	11230	4.32
UC3854ADW	DW	SOIC	16	40	507	12.83	5080	6.6
UC3854ADW.A	DW	SOIC	16	40	507	12.83	5080	6.6
UC3854ADWG4	DW	SOIC	16	40	507	12.83	5080	6.6
UC3854AN	N	PDIP	16	25	506	13.97	11230	4.32
UC3854AN.A	N	PDIP	16	25	506	13.97	11230	4.32
UC3854ANG4	N	PDIP	16	25	506	13.97	11230	4.32
UC3854BDW	DW	SOIC	16	40	507	12.83	5080	6.6
UC3854BDW.A	DW	SOIC	16	40	507	12.83	5080	6.6
UC3854BDWG4	DW	SOIC	16	40	507	12.83	5080	6.6
UC3854BN	N	PDIP	16	25	506	13.97	11230	4.32
UC3854BN.A	N	PDIP	16	25	506	13.97	11230	4.32
UC3854BNG4	N	PDIP	16	25	506	13.97	11230	4.32

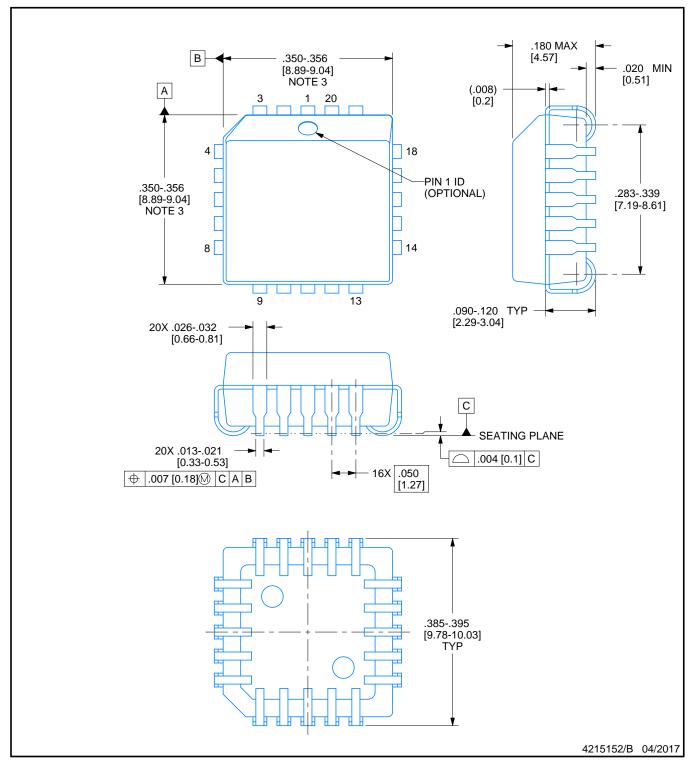


Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040005-2/C



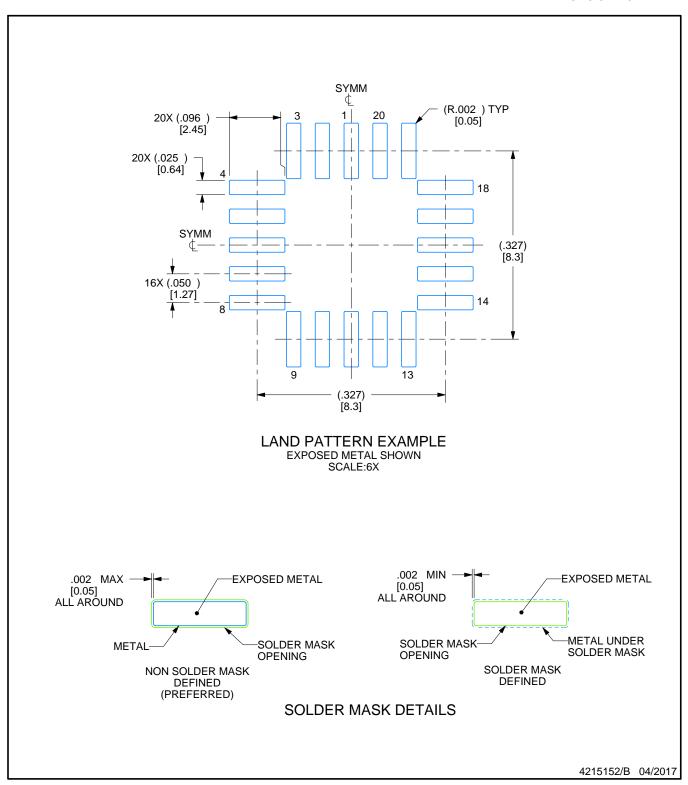




NOTES:

- 1. All linear dimensions are in inches. Any dimensions in brackets are in millimeters. Any dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. Dimension does not include mold protrusion. Maximum allowable mold protrusion .01 in [0.25 mm] per side. 4. Reference JEDEC registration MS-018.

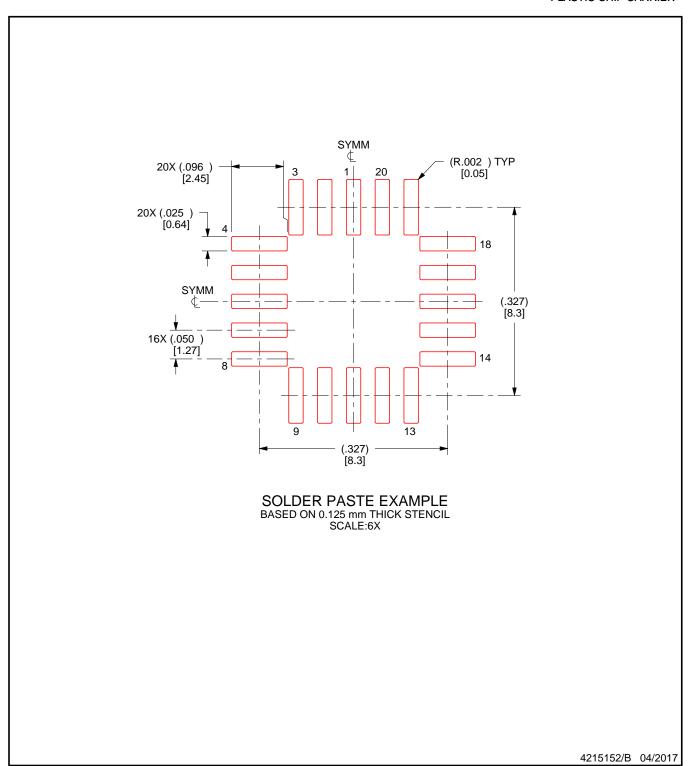




NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



7.5 x 10.3, 1.27 mm pitch

SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



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14 LEADS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



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